

Features

- Uses PingWei advanced PerfectMOS3 technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- Qualified according to AEC-Q101 criteria

Benefits

- High robustness and reliability
- Increases maximum current capability
- Low power loss, high power density

Applications

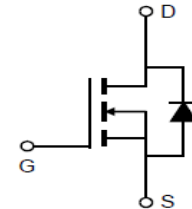
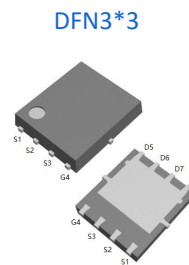
- General automotive applications
- Battery management
- UPS (Uninterruptible Power Supplies)



100% DVDS Tested
100% Avalanche Tested

Product Summary

V_{DS}	40V
$R_{DS(on)@10V \text{ typ}}$	4mΩ
I_D (Silicon limit)	62A



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
PWC050N04HS3Q	C050N04HS3Q	DFN3*3	Tape&Reel	13 inches	12mm	5000pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	40	V
Continuous drain current	I_D	62	A
$T_C = 25^\circ\text{C}$ (Silicon limit)		40	
$T_C = 25^\circ\text{C}$ (Package limit)		44	
$T_C = 100^\circ\text{C}$ (Silicon limit)		17	
$T_a = 25^\circ\text{C}$ (See RthJA)			
Pulsed drain current ($T_C = 25^\circ\text{C}, t_p=100\mu\text{s}$)	$I_{D \text{ pulse}}$	200	A
Avalanche energy, single pulse ($L=0.1\text{mH}, V_{ds}=32\text{V}$)	E_{AS}	31	mJ
Gate-Source voltage	V_{GS}	± 20	V
Power dissipation	P_{tot}	34	W
$T_C = 25^\circ\text{C}$			
Operating junction and storage temperature	T_j, T_{stg}	-55...+175	$^\circ\text{C}$
Reflow soldering temperature (10s)	T_{sold}	260	$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction – case.	RthJC	-	-	4.4	°C/W	-
Thermal resistance, junction - ambient	RthJA	-	-	59	°C/W	40x40x1.6mm,2oz single copper FR-4 PCB

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV_{DSS}	40	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate threshold voltage	$V_{GS(th)}$	2.0	-	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Zero gate voltage drain current	I_{DSS}	-	0.01	1	μA	$V_{DS}=40V, V_{GS}=0V$ $T_j=25^\circ C$ $T_j=125^\circ C$
Gate-source leakage current	I_{GSS}	-	± 10	± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	4.0	5.0	mΩ	$V_{GS}=10V, I_D=20A$ $V_{GS}=7V, I_D=10A$
Transconductance	g_{fs}	-	23	-	S	$V_{DS}=5V, I_D=20A$

Dynamic Characteristic

Input Capacitance	C_{iss}	-	1110	1665	pF	$V_{GS}=0V, V_{DS}=20V,$ $f=250KHz$
Output Capacitance	C_{oss}	-	410	615		
Reverse Transfer Capacitance	C_{rss}	-	25	40		
Gate Total Charge	Q_G	-	18	29	nC	$V_{DS}=20V, I_D=20A,$ $V_{GS}=10V$
Gate-Source charge	Q_{gs}	-	6	10		
Gate-Drain charge	Q_{gd}	-	4	8		
Turn-on delay time	$t_{d(on)}$	-	8	-	ns	$V_{GS}=10V, V_{DD}=20V,$ $R_{G_ext}=1.6\Omega, I_D=20A$
Rise time	t_r	-	23	-		
Turn-off delay time	$t_{d(off)}$	-	19	-		
Fall time	t_f	-	5	-		
Gate resistance	R_G	-	2.6	5	Ω	$V_{GS}=0V, V_{DS}=0V,$ $f=1MHz$

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	-	1.2	V	$V_{GS}=0V, I_{SD}=20A$
Body Diode Continuous Forward Current	I_S	-	-	40	A	TC = 25°C
Body Diode Pulsed Current	I_S pulse	-	-	200	A	TC = 25°C, $t_p=100\mu s$
Body Diode Reverse Recovery Time	t_{rr}	-	20	-	ns	$V_D=20V, I_F=20A,$ $dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{rr}	-	9	-	nC	

Typical Performance Characteristics

Fig 1: Output Characteristics

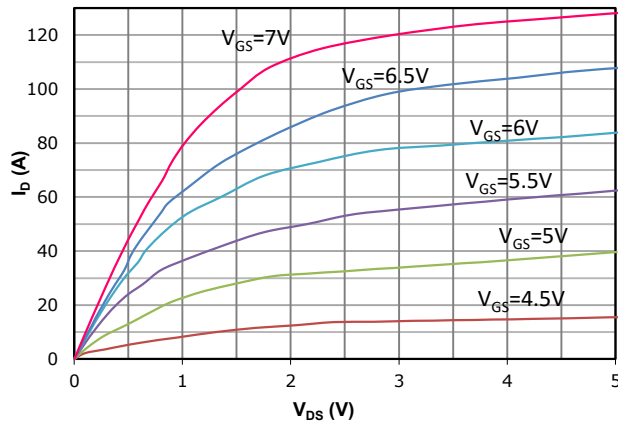


Fig 2: Transfer Characteristics

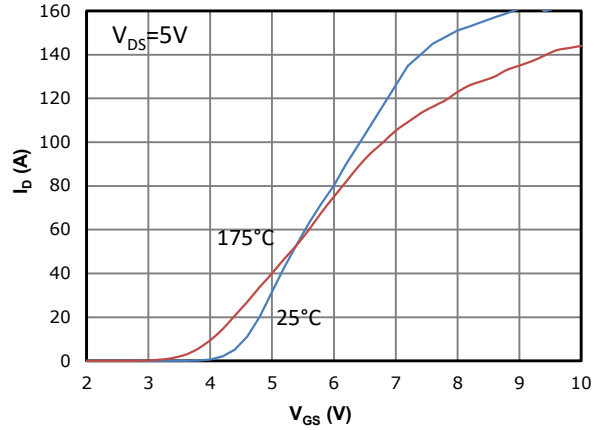


Fig 3: $R_{DS(on)}$ vs Drain Current and Gate Voltage

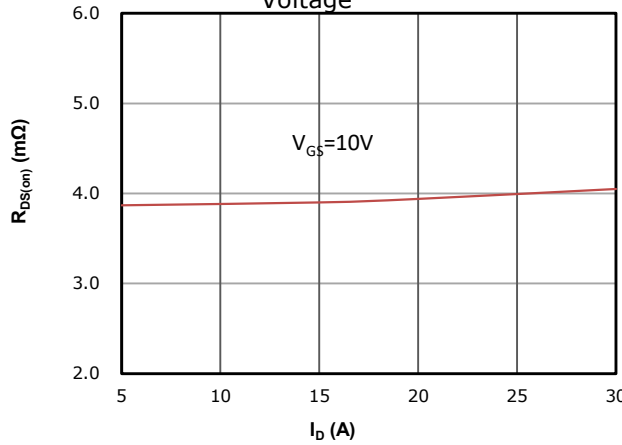


Fig 4: $R_{DS(on)}$ vs Gate Voltage

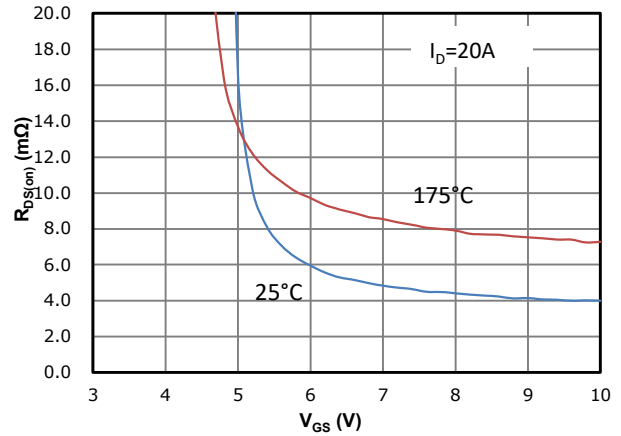


Fig 5: $R_{DS(on)}$ vs. Temperature

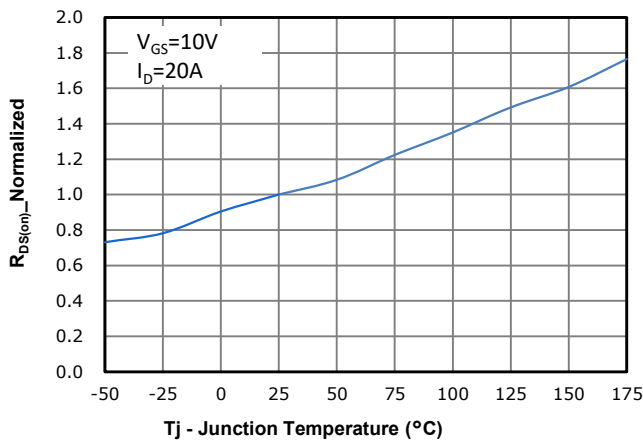


Fig 6: $V_{GS(th)}$ vs. Temperature

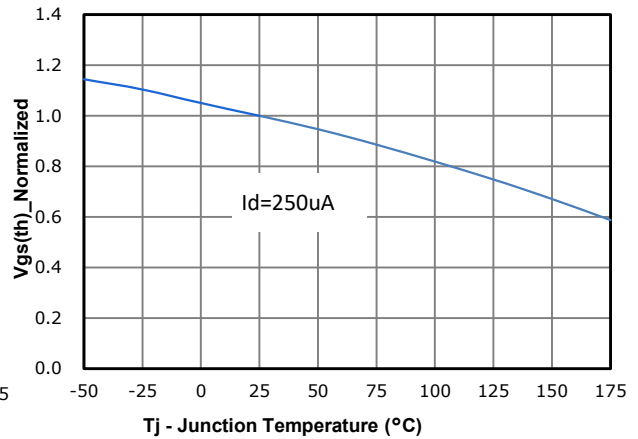


Fig 7: BVdss vs. Temperature

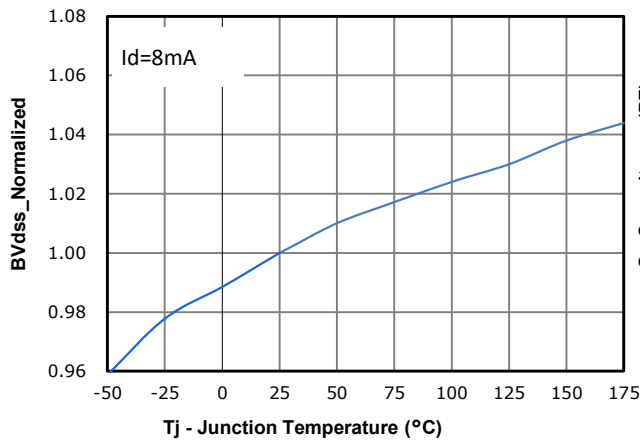


Fig 8: Capacitance Characteristics

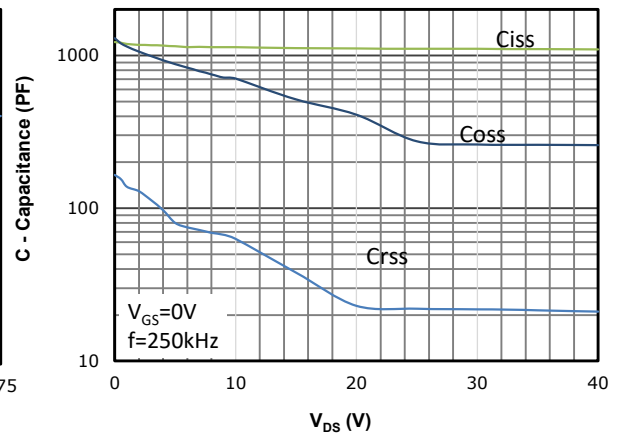


Fig 9: Gate Charge Characteristics

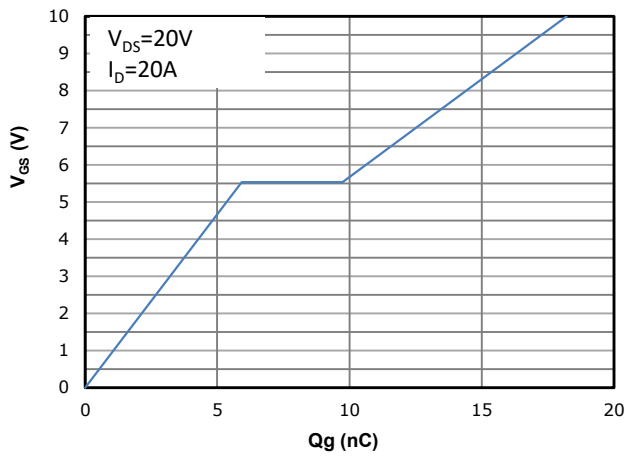


Fig 10: Body-diode Forward Characteristics

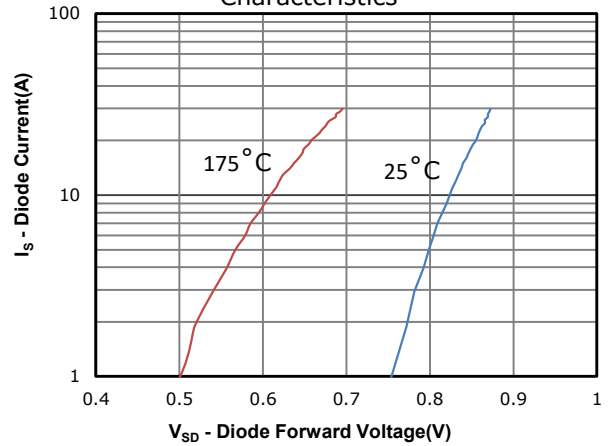


Fig 11: Power Dissipation

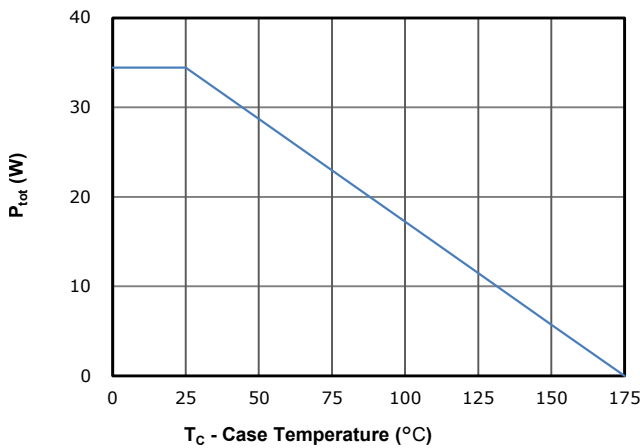


Fig 12: Drain Current Derating

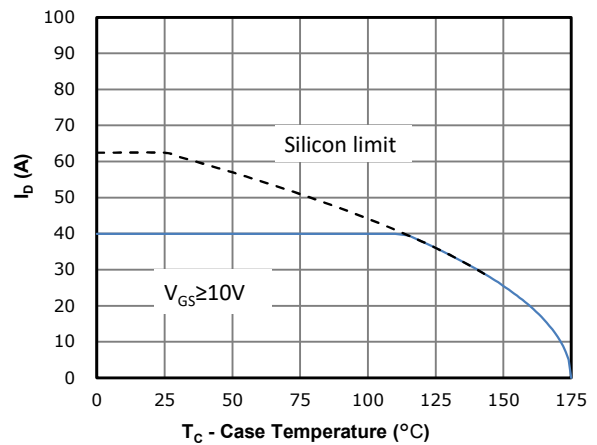


Fig 13: Safe Operating Area

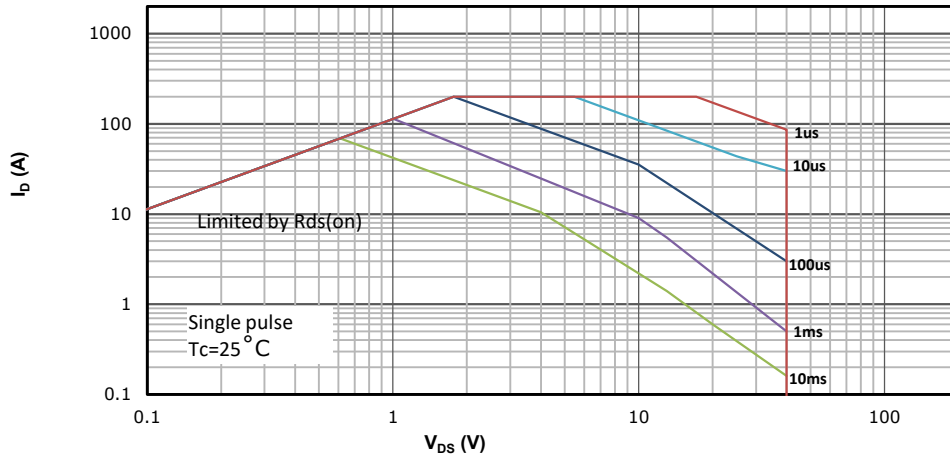
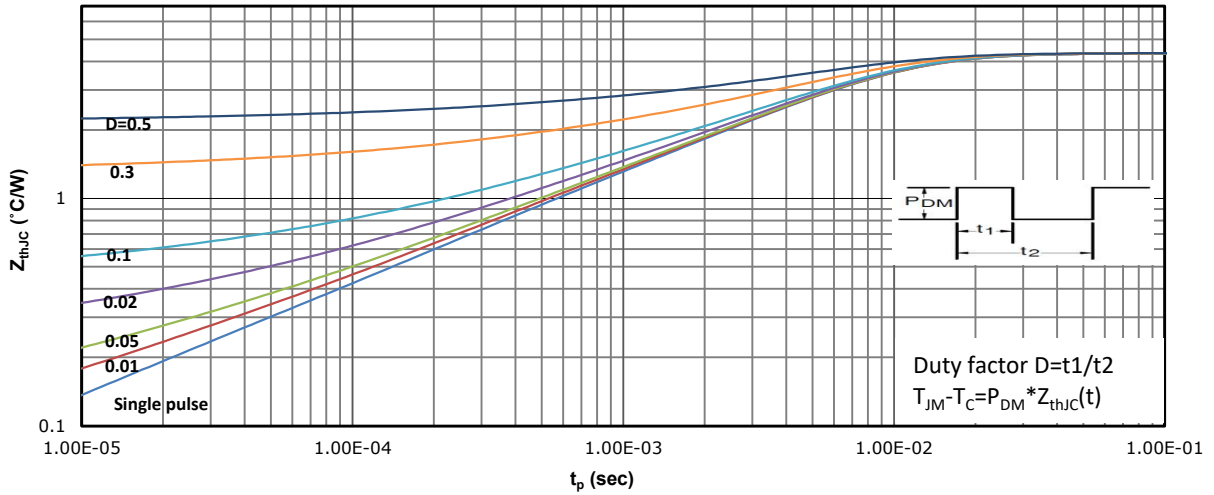
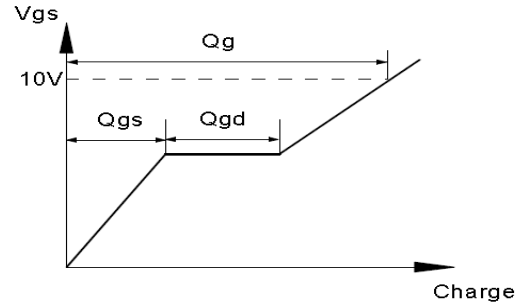
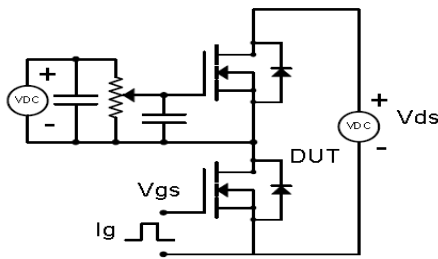


Fig 14: Max. Transient Thermal Impedance

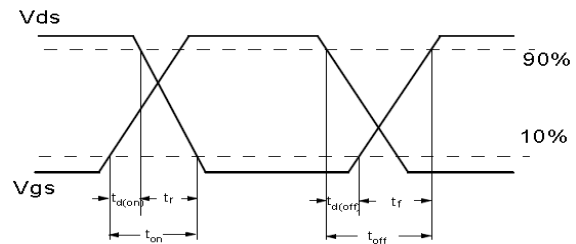
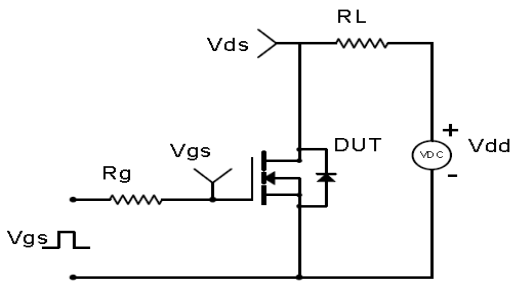


Test Circuit & Waveform

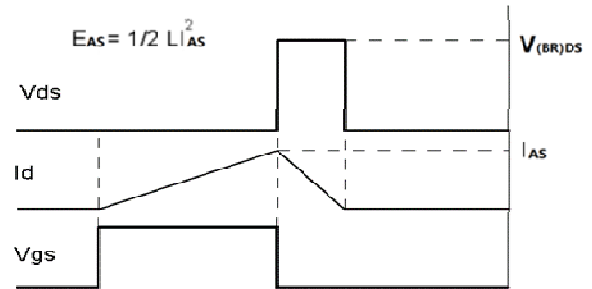
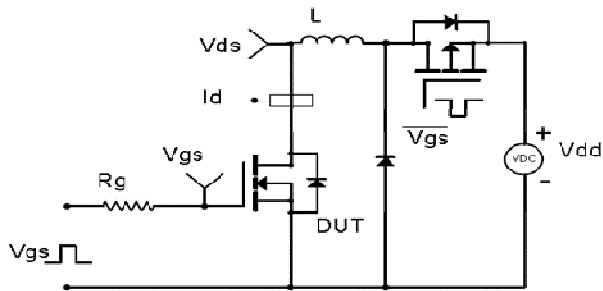
Gate Charge Test Circuit & Waveform



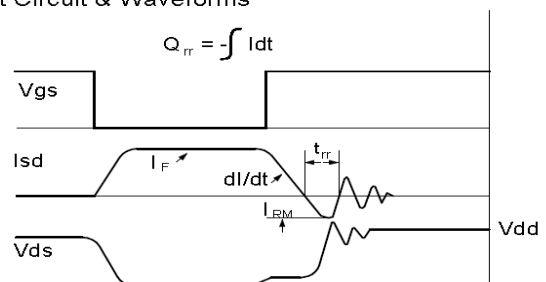
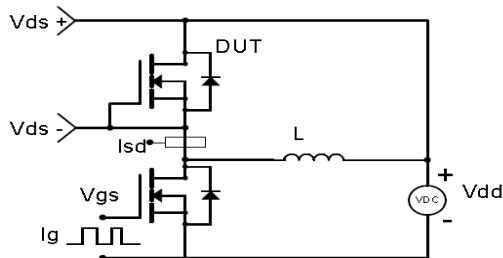
Resistive Switching Test Circuit & Waveforms



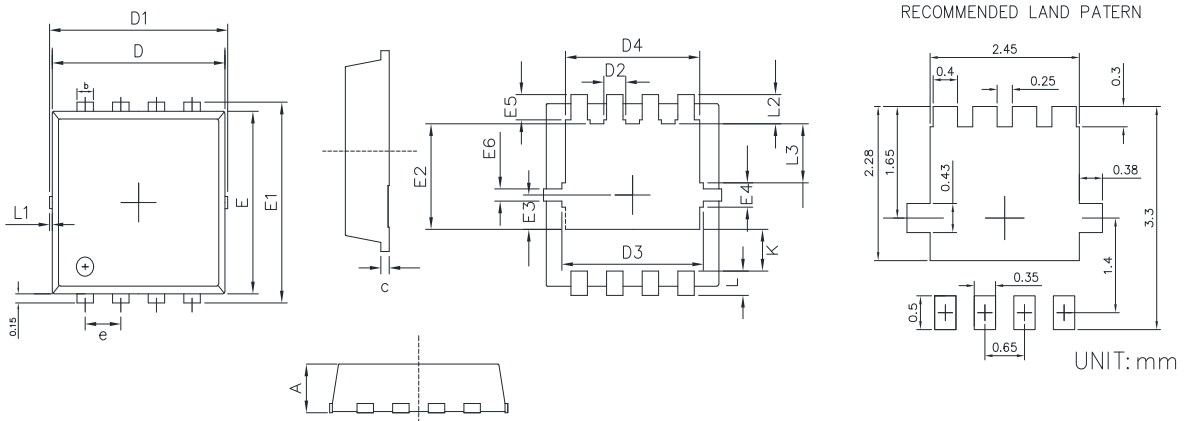
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: DFN3*3



SYMBOL	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.70	1.00	0.028	0.039
b	0.24	0.40	0.009	0.016
c	0.10	0.25	0.004	0.010
D	3.00	3.25	0.118	0.128
D1	3.10	3.50	0.122	0.138
D2	0.30	0.50	0.012	0.020
D3	2.50	2.70	0.098	0.106
D4	2.35	2.55	0.093	0.100
E	2.90	3.10	0.114	0.122
E1	3.15	3.45	0.124	0.136
E2	1.65	1.85	0.065	0.073
E3	0.48	0.68	0.019	0.027
E4	0.23	0.50	0.009	0.020
E5	0.20	0.40	0.008	0.016
E6	0.08	0.25	0.003	0.010
e	0.55	0.75	0.022	0.030
K	0.52	0.82	0.020	0.032
L	0.25	0.55	0.010	0.022
L1	0.00	0.10	0.000	0.004
L2	0.28	0.58	0.011	0.023
L3	0.88	1.08	0.035	0.043



Revision History

Revision	Date	Major changes
1.0	2026/1/19	Release of Normal Version.

Disclaimer

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

The product is not intended for use in applications that require extraordinary levels of quality and reliability, such as aviation/aerospace and life-support devices or systems.

Buyer is responsible for its products and applications using PingWei products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by PingWei.

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